

The Model MCPS-CF enables cost effective, stable, reliable and convenient probing of devices and circuits at very low temperatures and at large magnetic fields. Built-in vibration isolation, smart thermal management, and engineered thermal expansion compensation makes this system ideally suited for a wide range of applications spanning from nanoelectronics (spintronic research, molecular electronics, etc.) to space based electronics. The system uses closed-cycle refrigerator and proprietary thermal management permitting inexpensive and fast operations. Built-in vibration isolation minimizes the vibrations to industry-standard levels. Ultra-stable micro-manipulated stages permit accurate and reproducible contact of the probe tip on device features. Wide selection of the probes and wafer chucks permit applications ranging from ultraprecise, fA-scale measurements, RF measurements and many more.

Key Features

- Cost- competitive, stable, reliable, and convenient to use
- Temperature range from 10K to 400K (0.1K accuracy) with 4.2K to 480K (optional)
- Closed- cycle refrigerator for cost effective cryogen-free operations
- Characterization of up to 1" diameter samples (up to 2" diameter optional)
- DC to 67GHz measurements
- 4 micromanipulated probe arms (up to 6 available in optional configurations), with highly accurate XYZ and optionally $\boldsymbol{\theta}$ adjustment
- Thermally anchored probe tips
- Temperature- controlled radiation shield
- Clear view top window (high purity quartz)
- High frequency vibration damping
- Integration with electromagnet for horizontal magnetic field generation
- High level of customization to accommodate most exotic probing needs





Specifications: Sample size Up to 50mm round Thermal specifications Cryogen-free closed cycle refrigerator including cold head, compressor, chiller and required helium hoses **Temperature range**: standard 10K to 400K, 4.2K to 480K available as options - **Temperature accuracy**: 0.1K Thermally anchored prone arms and radiation shield Temperature controlled (heater) chuck Temperature monitoring of the chuck and probe arm Temperature monitoring of radiation shield is optional Vacuum Base pressure 1.0×10^{-5} torr standard, down to sub-10⁻⁶ torr optional Optics Additional viewports: can be added by customer Window materials: fused silica, custom materials and coatings are available Microscope: Extra-long working distance stereo-zoom microscope Eyepieces with reticles: 10x, 20x **Working distance**: 75mm at 10x magnification Trinocular vision for simultaneous eyepiece viewing and camera viewing Coaxial illumination with optional programmable shutter Cameras: Digital cameras ranging from 1 megapixel to 10 megapixels. Included with the camera is software for image and video capture as well as dimension measurement capability

MCPS-CF

www.microxact.com Phone: 540-394-4040 Fax: 1-866-588-0908

Specifications (cont.):	
Probes	DCRF (various)ActiveHigh power
Micromanipulators	- Various resolutions and ranges available
Cables available	 Cryogenic temperature- compatible coaxial cables Cryogenic temperature-compatible coaxial triaxial cable
Wafer chucks available	 Grounded Isolated Coaxial Triaxial All wafer chucks are planar to within 15µm at room temperature Thermal expansion is compensated to a large part by design
Software	- LabView-based software for computer control and monitoring of temperatures. Several temperature testing sequences are pre-programmed and custom sequences can be easily programmed by the end user
Vibration isolation	 Vibration isolation table with air damping system Vibration- isolating bellows
Options	Fiber optic probesHigh level of customization to the customer needs
Magnetic field generation	 Horizontal magnetic field, up to 0.5T Range of power supplies available (unipolar or true bipolar) Hall probe for active magnetic field control is optional

MCPS-CF

www.microxact.com Phone: 540-394-4040 Fax: 1-866-588-0908